Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/634,122	LUONG ET AL.
Examiner	Art Unit
James Phan	2872

	SEAR	CHED	
Class	Subclass	Date	Examiner
359	900	8/05	7%
264	165		
	172.19		
427	2.31		
428,	423.1		
' '			
5281	423.3 60,44,		
	59		
	·		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		L	

SEARCH NOT (INCLUDING SEARCH S)
	DATE	EXMR
EAST. See attachmants	8/05	JP-